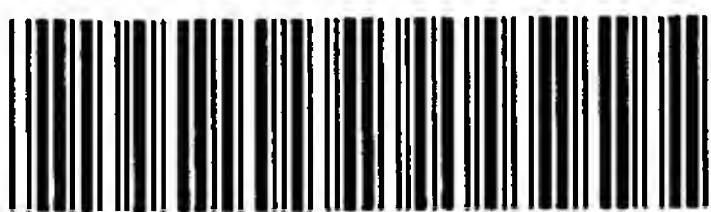


Search Notes



Application/Control No.

**Applicant(s)/Patent under
Reexamination**

10/511,270

NAKAJIMA ET AL.

Examiner

Art Unit

Rita Mitra

1656

SEARCHED

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
530	23.1,23.5	10/29/2007	RM
435	69.1 320.1	10/29/2007	RM
530	300 350	10/29/2007	RM
STIC conducted sequence search		10/29/2007	RM

SEARCH NOTES (INCLUDING SEARCH STRATEGY)